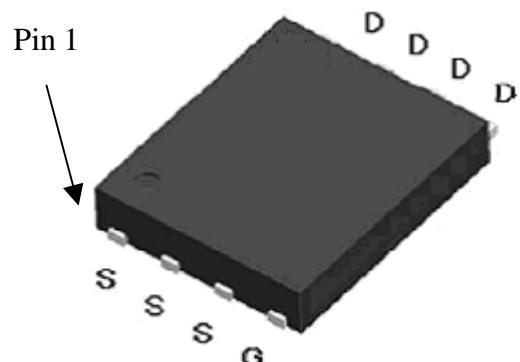


## P-Channel Enhancement Mode Power MOSFET

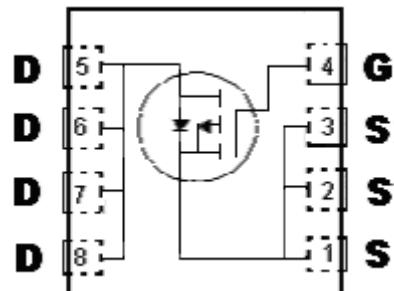
### Features:

- Single Drive Requirement
- Low On-resistance
- Fast Switching Characteristic
- Pb-free lead plating and Halogen-free package



EDFN5x6

BVdss	-30V	
ID@VGS=-10V, Tc=25°C	-90A	
ID@VGS=-10V, TA=25°C	-22A	
RDSON(TYP)	VGS=-10V, ID=-20A	3.2mΩ
	VGS=-4.5V, ID=-17A	5.1mΩ



G : Gate D : Drain S : Source

### Ordering Information

Device	Package	Shipping
KWB5D0P03H8	DFN5x6 (Pb-free lead plating and halogen-free package)	3000 pcs / Tape & Reel

## Absolute Maximum Ratings ( $T_a=25^{\circ}\text{C}$ )

Parameter	Symbol	10s	Steady State	Unit
Drain-Source Voltage	$V_{DS}$	-30		<b>V</b>
Gate-Source Voltage	$V_{GS}$	+25		
Continuous Drain Current @ $T_c=25^{\circ}\text{C}$ , $V_{GS}=-10\text{V}$ (Note1)	$I_D$	-90		<b>A</b>
Continuous Drain Current @ $T_c=100^{\circ}\text{C}$ , $V_{GS}=-10\text{V}$ (Note1)		-57		
Continuous Drain Current @ $T_a=25^{\circ}\text{C}$ , $V_{GS}=-10\text{V}$ (Note2)	$I_{DSM}$	-22	-14.2	
Continuous Drain Current @ $T_a=70^{\circ}\text{C}$ , $V_{GS}=-10\text{V}$ (Note2)		-17.6	-11.4	
Pulsed Drain Current (Note3)	$I_{DM}$	-200 *1,2		
Avalanche Current	$I_{AS}$	-30		
Avalanche Energy @ $L=0.1\text{mH}$ , $I_D=-30\text{A}$ , $V_{DD}=-15\text{V}$	$E_{AS}$	45		<b>mJ</b>
Total Power Dissipation	$P_D$	$T_c=25^{\circ}\text{C}$ (Note1)	83.3	<b>W</b>
		$T_c=100^{\circ}\text{C}$ (Note1)	33.3	
	$P_{DSM}$	$T_a=25^{\circ}\text{C}$ (Note2)	5.0	
		$T_a=70^{\circ}\text{C}$ (Note2)	3.2	
Operating Junction and Storage Temperature Range	$T_j$ , $T_{stg}$	-55~+150		$^{\circ}\text{C}$

## Thermal Data

Parameter	Symbol	Typical	Maximum	Unit
Thermal Resistance, Junction-to-case	$R_{th,j-c}$	1	1.5	$^{\circ}\text{C}/\text{W}$
Thermal Resistance, Junction-to-ambient (Note2)	$R_{th,j-a}$	18	25	$^{\circ}\text{C}/\text{W}$
		50	60	

- Note : 1. The power dissipation  $P_D$  is based on  $T_{j(\text{MAX})}=150^{\circ}\text{C}$ , using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.  
 2. The value of  $R_{\theta JA}$  is measured with the device mounted on 1 in<sup>2</sup> FR-4 board with 2 oz. copper, in a still air environment with  $T_a=25^{\circ}\text{C}$ . The power dissipation  $P_{DSM}$  is based on  $R_{\theta JA}$  and the maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design.  
 3. Repetitive rating, pulse width limited by junction temperature  $T_{j(\text{MAX})}=150^{\circ}\text{C}$ . Ratings are based on low frequency and low duty cycles to keep initial  $T_j=25^{\circ}\text{C}$ .

## Characteristics ( $T_c=25^{\circ}\text{C}$ , unless otherwise specified)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
<b>Static</b>					
$BV_{DSS}$	-30	-	-	<b>V</b>	$V_{GS}=0\text{V}$ , $I_D=-250\mu\text{A}$
$V_{GS(\text{th})}$	-1.0	-	-2.5	<b>V</b>	$V_{DS} = V_{GS}$ , $I_D=-250\mu\text{A}$
$G_{FS}$ *1	-	58	-	<b>S</b>	$V_{DS}=-5\text{V}$ , $I_D=-20\text{A}$
$I_{GSS}$	-	-	$\pm 100$	$\text{nA}$	$V_{GS}=\pm 25\text{V}$
$I_{DSS}$	-	-	-1	$\mu\text{A}$	$V_{DS}=-24\text{V}$ , $V_{GS}=0\text{V}$
	-	-	-25		$V_{DS}=-24\text{V}$ , $V_{GS}=0$ , $T_j=125^{\circ}\text{C}$
$R_{DS(\text{ON})}$ *1	-	3.2	5.5	$\text{m}\Omega$	$V_{GS}=-10\text{V}$ , $I_D=-20\text{A}$
	-	5.1	8.5	$\text{m}\Omega$	$V_{GS}=-4.5\text{V}$ , $I_D=-17\text{A}$

<b>Dynamic *4</b>					
C <sub>iss</sub>	-	8120	-	pF	V <sub>DS</sub> =-15V, V <sub>GS</sub> =0V, f=1MHz
C <sub>oss</sub>	-	919	-		
C <sub>rss</sub>	-	878	-		
Q <sub>g</sub> *1, 2	-	121	181	nC	V <sub>DS</sub> =-24V, V <sub>GS</sub> =-10V, I <sub>D</sub> =-20A
Q <sub>gs</sub> *1, 2	-	18.6	-		
Q <sub>gd</sub> *1, 2	-	24.5	-		
t <sub>d(ON)</sub> *1, 2	-	19.4	29	ns	V <sub>DS</sub> =-15V, I <sub>D</sub> =-20A, V <sub>GS</sub> =-10V, R <sub>G</sub> =2.7Ω
t <sub>r</sub> *1, 2	-	21.6	32		
t <sub>d(OFF)</sub> *1, 2	-	133	200		
t <sub>f</sub> *1, 2	-	49.2	74		
R <sub>g</sub>	-	3.8	-	Ω	f=1MHz
<b>Source-Drain Diode</b>					
V <sub>SD</sub> *1	-	-0.8	-1.2	V	I <sub>S</sub> =-20A, V <sub>GS</sub> =0V
trr	-	26	-	ns	
Qrr	-	17	-	nC	I <sub>F</sub> =-10A, dI <sub>F</sub> /dt=100A/μs

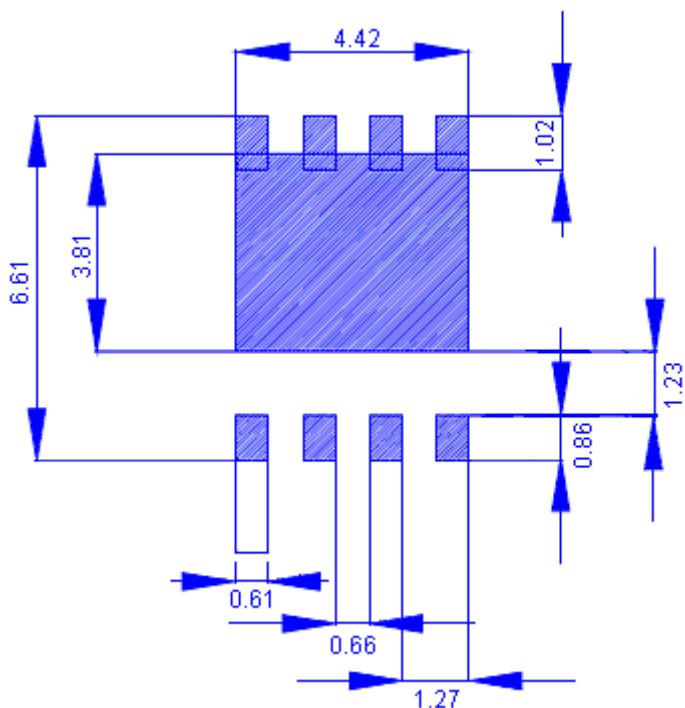
Note : \*1.Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%

\*2.Independent of operating temperature

\*3.Pulse width limited by maximum junction temperature.

\*4.Guaranteed by design, not subject to production testing.

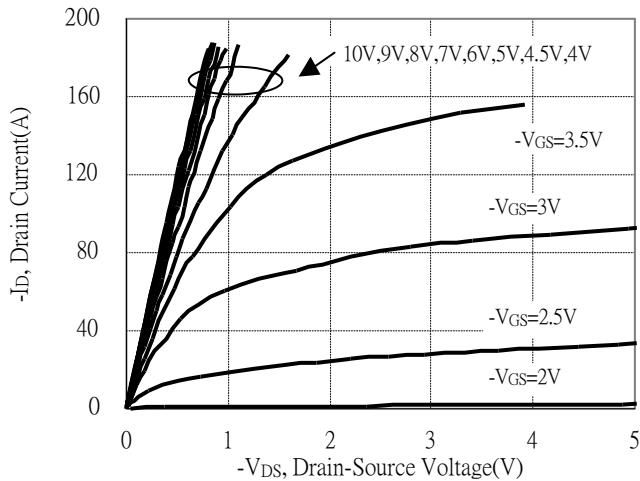
## Recommended Soldering Footprint



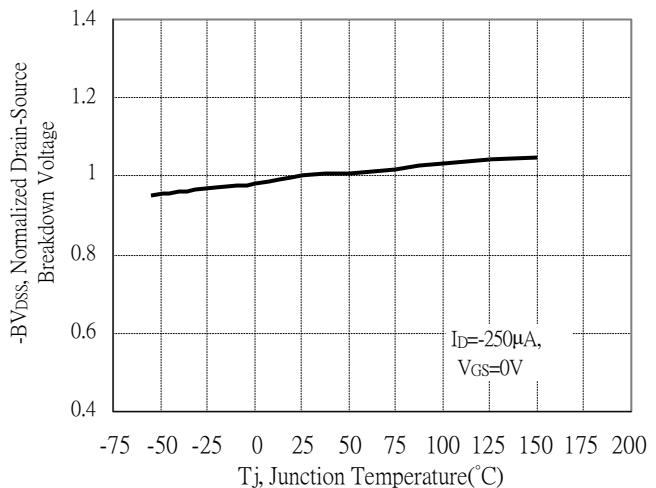
unit : mm

## Typical Characteristics

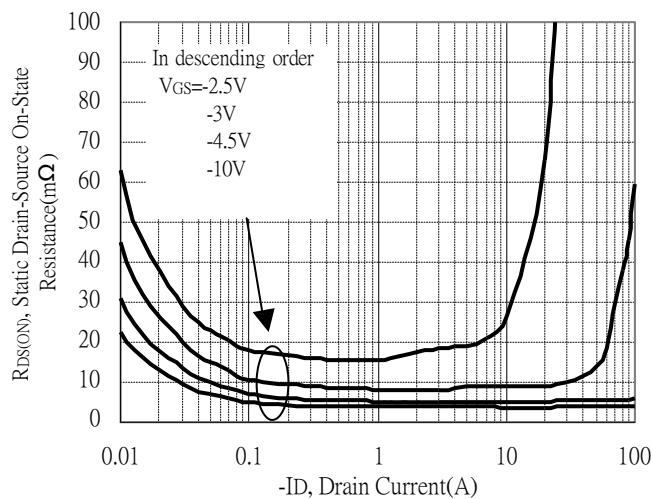
Typical Output Characteristics



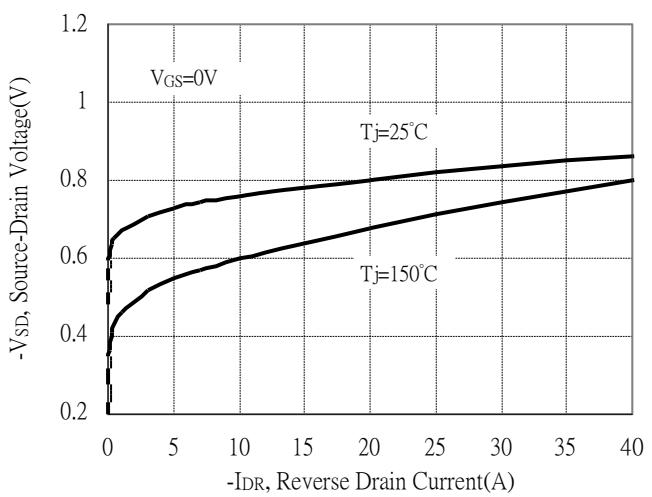
Breakdown Voltage vs Ambient Temperature



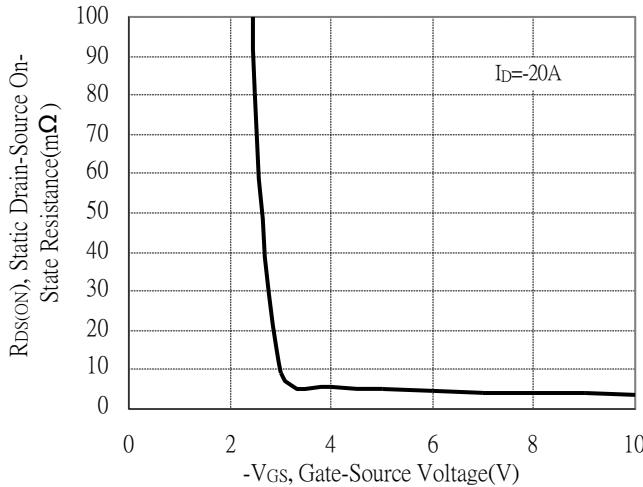
Static Drain-Source On-State resistance vs Drain Current



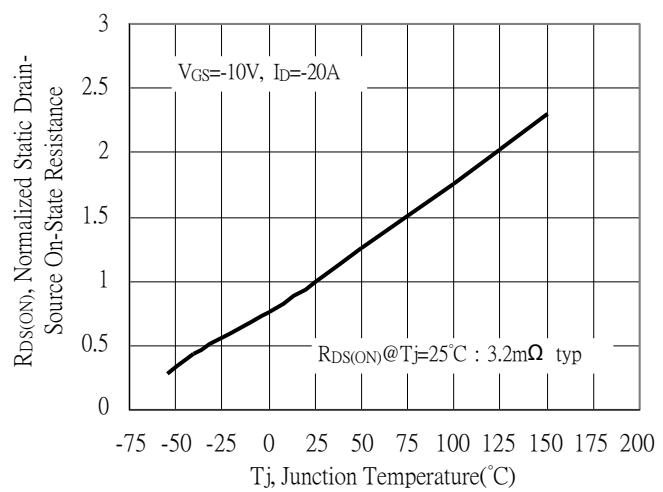
Reverse Drain Current vs Source-Drain Voltage



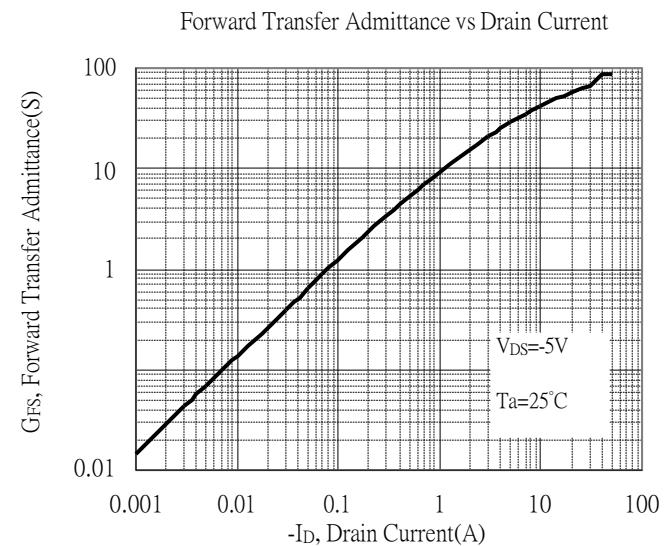
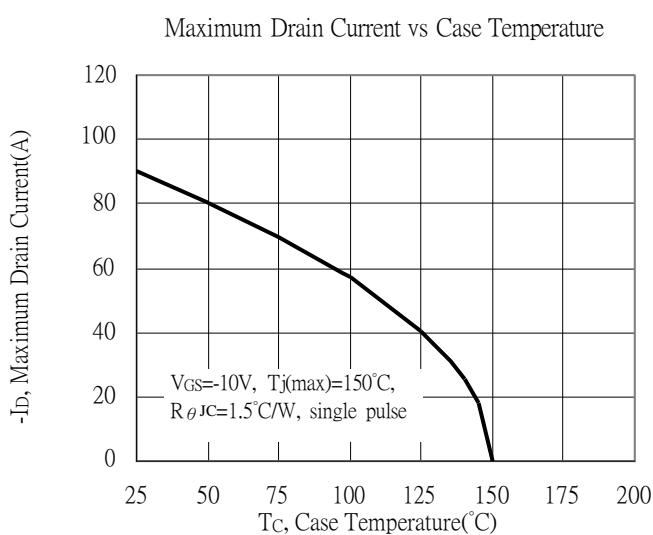
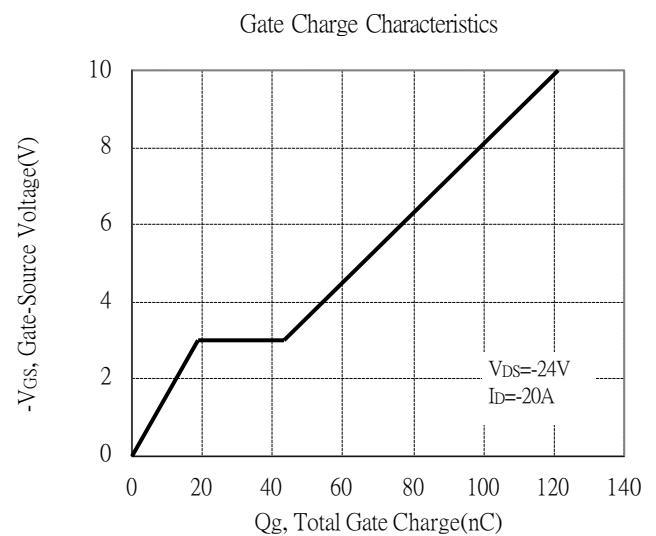
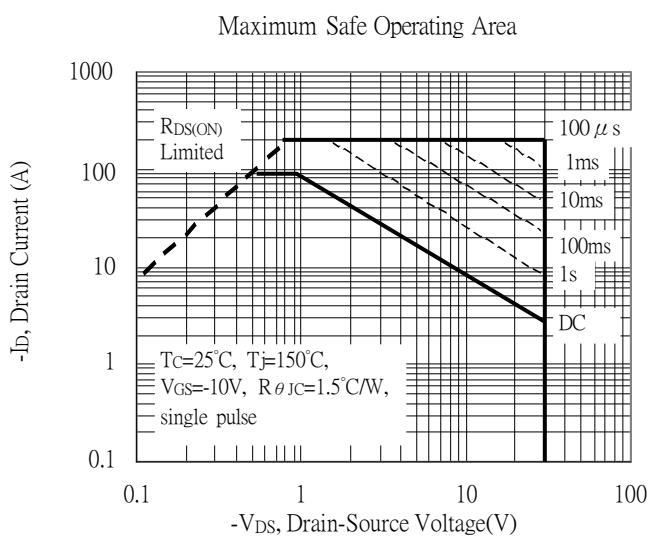
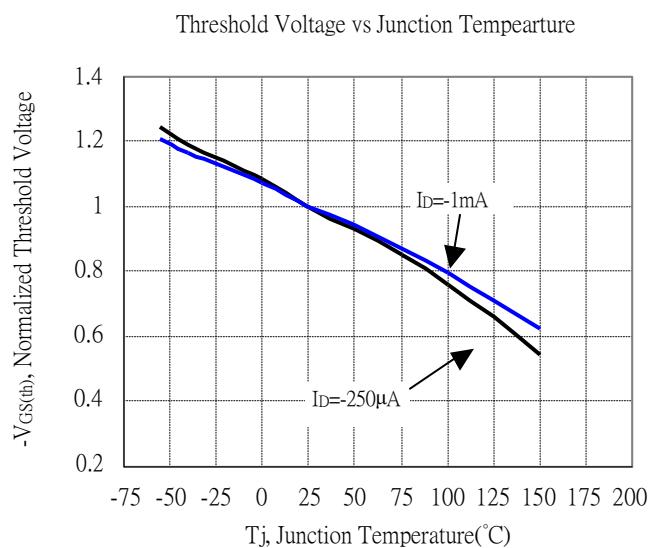
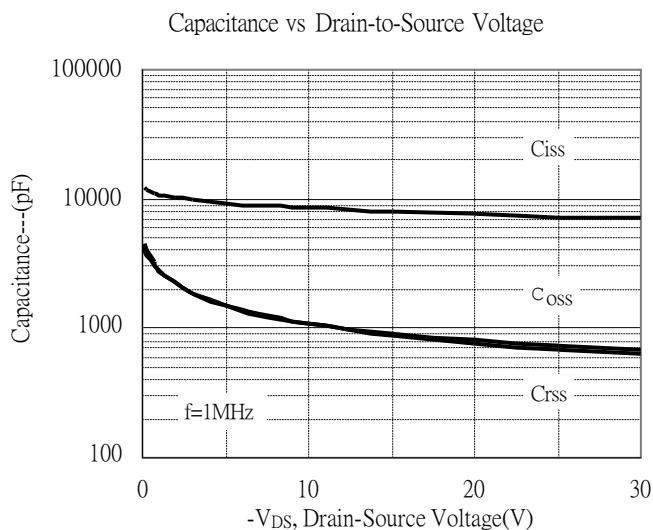
Static Drain-Source On-State Resistance vs Gate-Source Voltage



Drain-Source On-State Resistance vs Junction Temperature

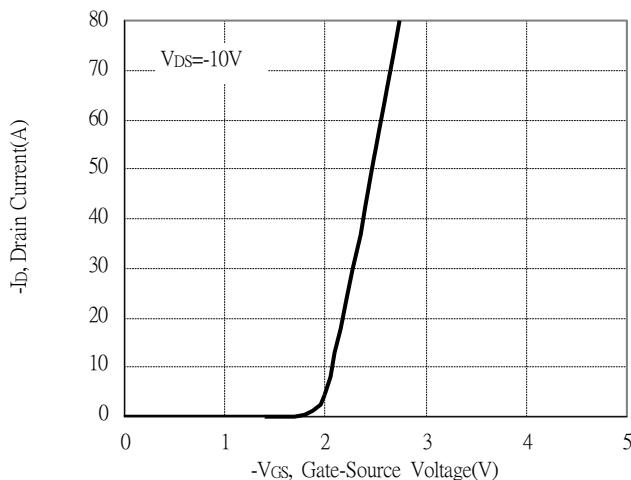


## Typical Characteristics(Cont.)

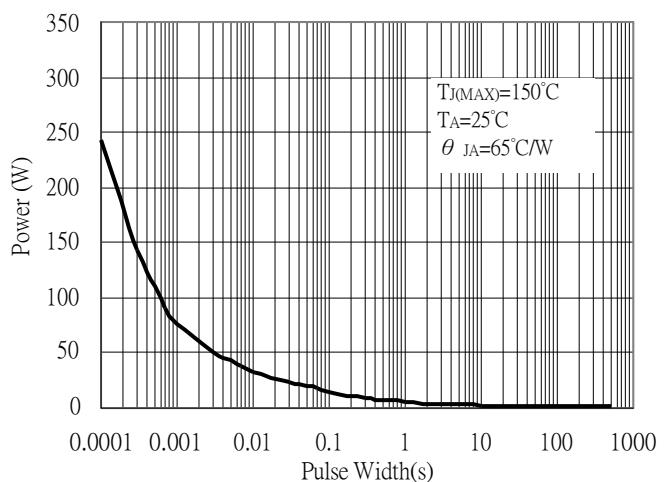


## Typical Characteristics(Cont.)

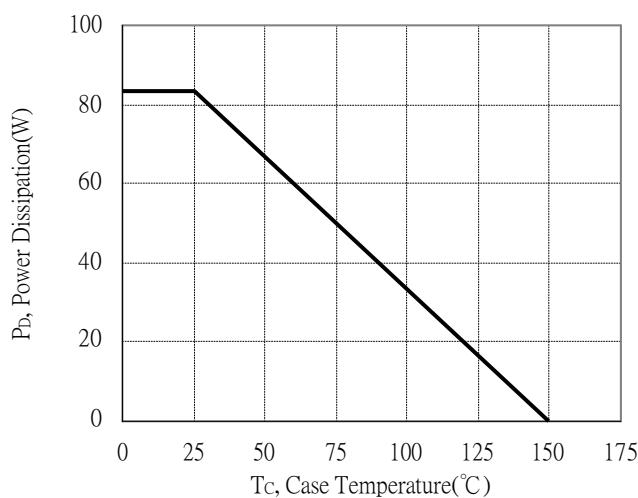
Typical Transfer Characteristics



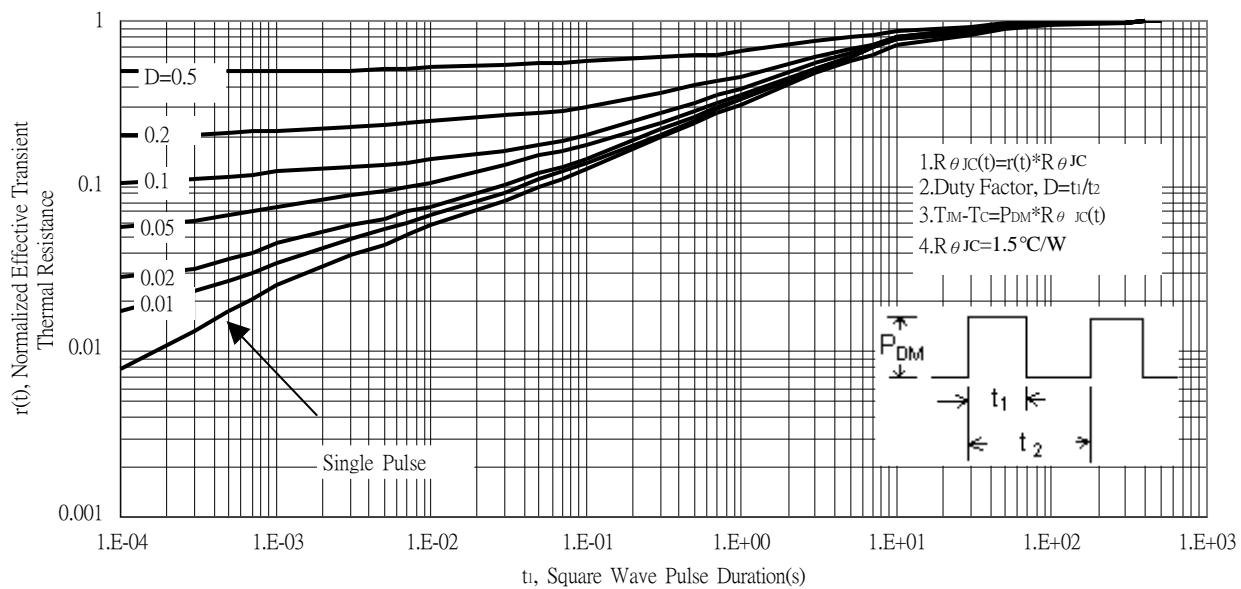
Single Pulse Maximum Power Dissipation



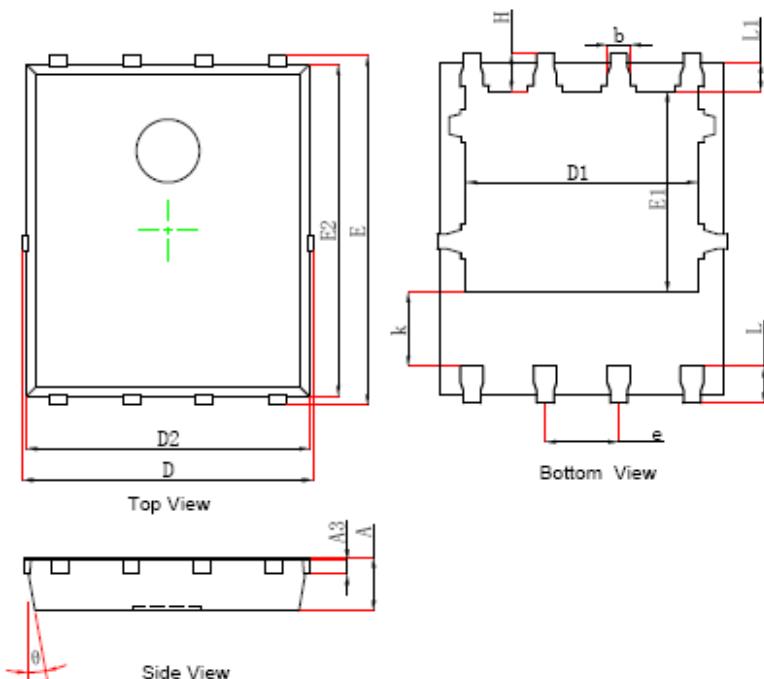
Power Derating Curve



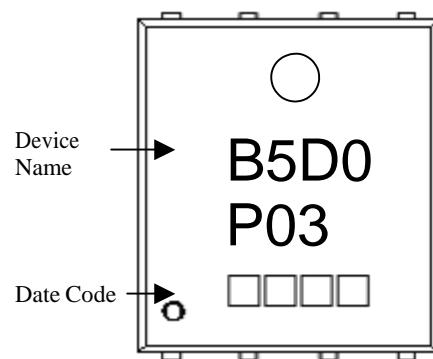
Transient Thermal Response Curves



## DFN5x6 Dimension



Marking :



8-Lead DFN5x6 Plastic  
 Package Code : H8

DIM	Millimeters		Inches		DIM	Millimeters		Inches	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	0.900	1.000	0.035	0.039	k	1.190	1.390	0.047	0.055
A3	0.254	REF	0.010	REF	b	0.350	0.450	0.014	0.018
D	4.944	5.096	0.195	0.201	e	1.270	TYP.	0.050	TYP.
E	5.974	6.126	0.235	0.241	L	0.559	0.711	0.022	0.028
D1	3.910	4.110	0.154	0.162	L1	0.424	0.576	0.017	0.023
E1	3.375	3.575	0.133	0.141	H	0.574	0.726	0.023	0.029
D2	4.824	4.976	0.190	0.196	θ	10°	12°	10°	12°
E2	5.674	5.826	0.223	0.229					